Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/806,338	OHASHI ET AL.	
Examiner	Art Unit	
David E. Martinez	2181	

David E. Martinez

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH)
·	DATE	EXMR
East see attached	8/3/2007	DM
inventor search east/palm	8/3/2007	DM
710/36-38.ccls. 714/1-4.ccls. with keywords and text search	8/3/2007	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	8/3/2007	DM
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